



US00D819581S

(12) **United States Design Patent** (10) **Patent No.:** **US D819,581 S**
Okushi et al. (45) **Date of Patent:** **** Jun. 5, 2018**

(54) **SOCKET FOR ELECTRONIC DEVICE TESTING APPARATUS**

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(**) Term: **15 Years**

(21) Appl. No.: **29/601,371**

(22) Filed: **Apr. 21, 2017**

Related U.S. Application Data

(62) Division of application No. 29/509,962, filed on Nov. 24, 2014, now Pat. No. Des. 788,722.

(30) **Foreign Application Priority Data**

Jul. 17, 2014 (KR) 30-2014-0035153
Jul. 17, 2014 (KR) 30-2014-0035155

(51) **LOC (11) Cl.** **13-03**

(52) **U.S. Cl.**
USPC **D13/182**

(58) **Field of Classification Search**
USPC D13/182

(Continued)

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Primary Examiner — Elizabeth J Oswecki
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(57) **CLAIM**

The ornamental design for a socket for an electronic device testing apparatus, as shown and described.

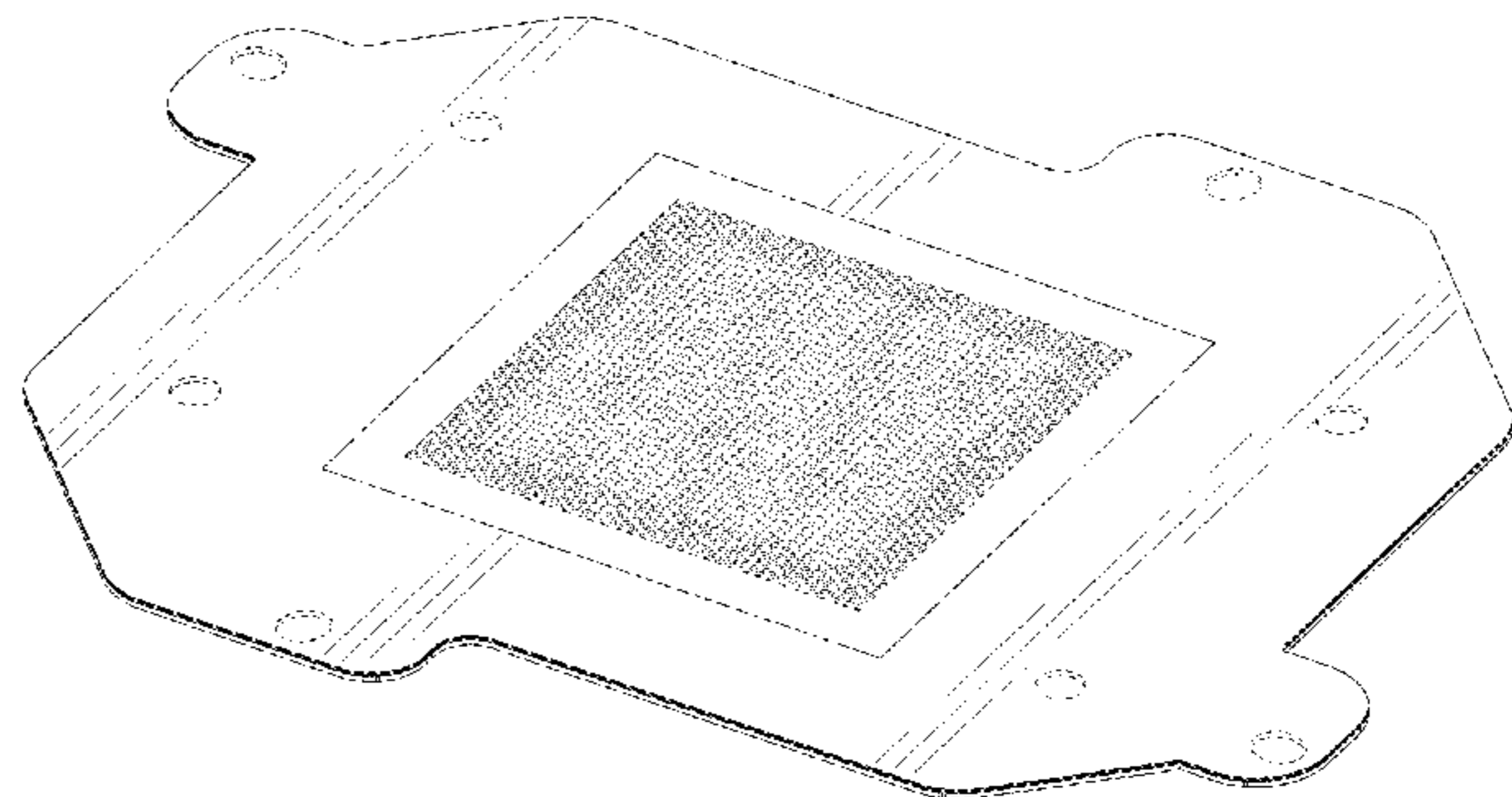
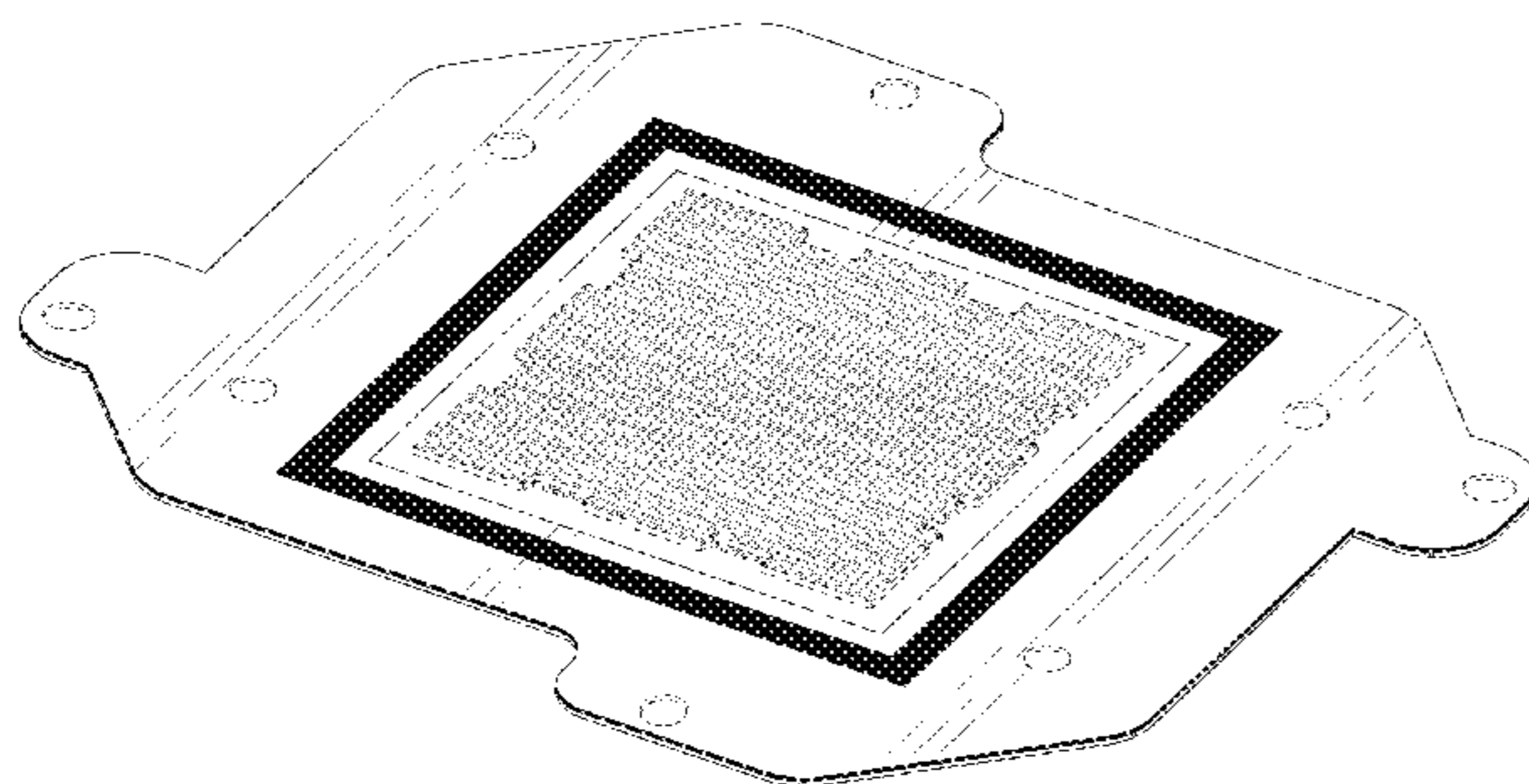
DESCRIPTION

FIG. 1 is a front view of a socket for electronic testing apparatus showing our new design; FIG. 2 is a rear view thereof; FIG. 3 is a top plan view thereof; FIG. 4 is a bottom plan view thereof; FIG. 5 is a right side view thereof; FIG. 6 is a left side view thereof; FIG. 7 is a top perspective view thereof; FIG. 8 is a bottom perspective view thereof; FIG. 9 is a cross-sectional view taken along line 9-9 of FIG. 3; FIG. 10 is a cross-sectional view taken along line 10-10 of FIG. 3; FIG. 11 is an enlarged portion view taken along line 11-11 of FIG. 9; and, FIG. 12 is an enlarged portion view taken along line 12-12 of FIG. 10.

The even dashed broken lines shown in the drawings represent portions of the socket for an electronic testing apparatus, that form no part of the claimed design.

The dashed-dot line shown on the top and bottom of the socket for an electronic testing apparatus represents the boundary line between the claimed and unclaimed surface areas.

(Continued)



The outer boarder of the center broken line circles in FIG. 8 that form no part of the claimed design, show the step in FIGS. 11 and 12.

1 Claim, 8 Drawing Sheets

(58) Field of Classification Search

CPC H05K 7/10; H05K 7/1084; H05K 7/00; H05K 7/02; H05K 7/06; H05K 7/1053; H05K 7/1092; H05K 7/14; H05K 7/18; H05K 1/0266; H05K 1/0268; H01R 12/00; H01R 12/50; H01R 12/51; H01R 2201/20; G01R 31/2801; G01R 31/2806; G01R 31/2808; G01R 31/2832; G01R 31/2818; G01R 31/281; G01R 31/282; G01R 31/2851; G01R 31/26; G01R 31/2601; G01R 31/2863; G01R 1/04; G01R 1/0408; G01R 1/0416; G01R 1/0425; G01R 1/0433; G01R 1/0441; G01R 1/045; G01R 1/0458; G01R 1/0466; G01R 1/0475; G01R 1/0483; G01R 1/067

See application file for complete search history.

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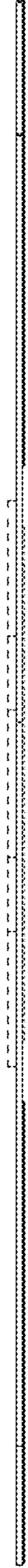


FIG. 1

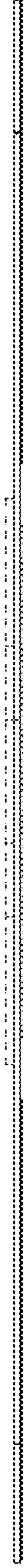
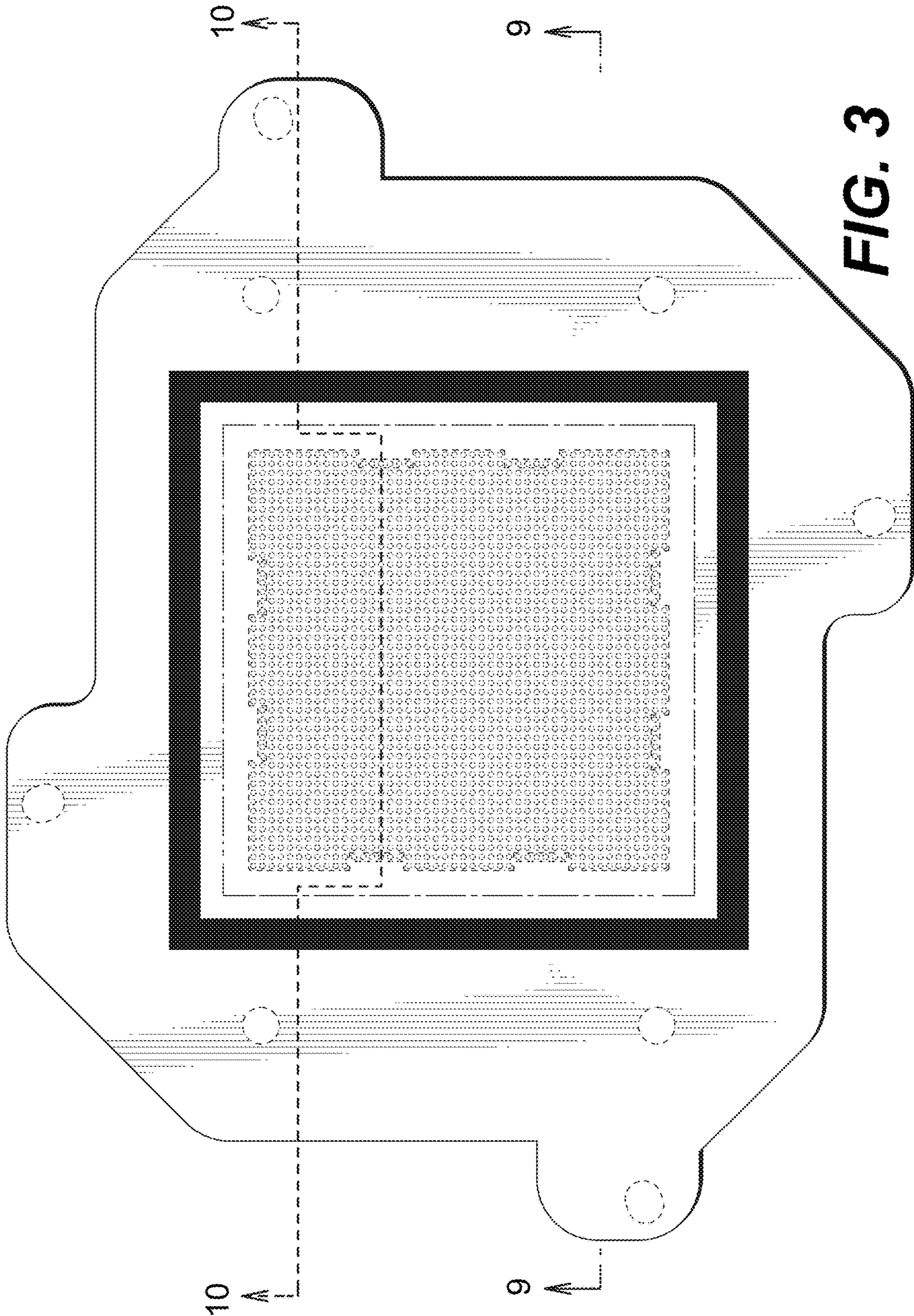


FIG. 2



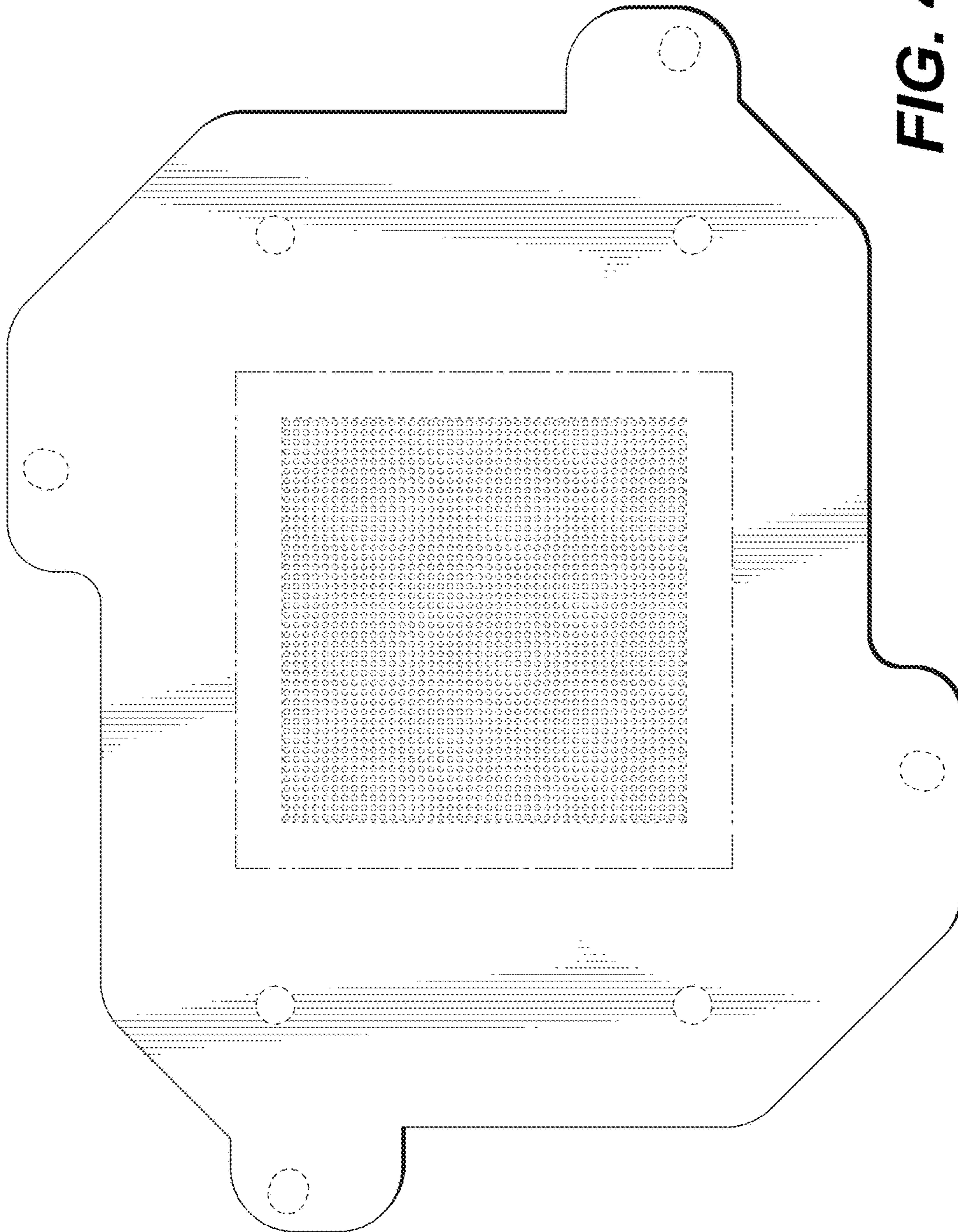


FIG. 4

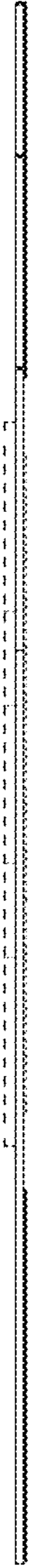


FIG. 5

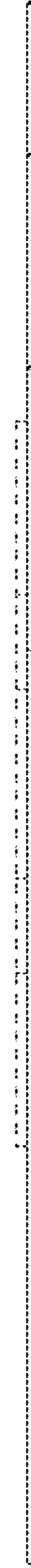


FIG. 6

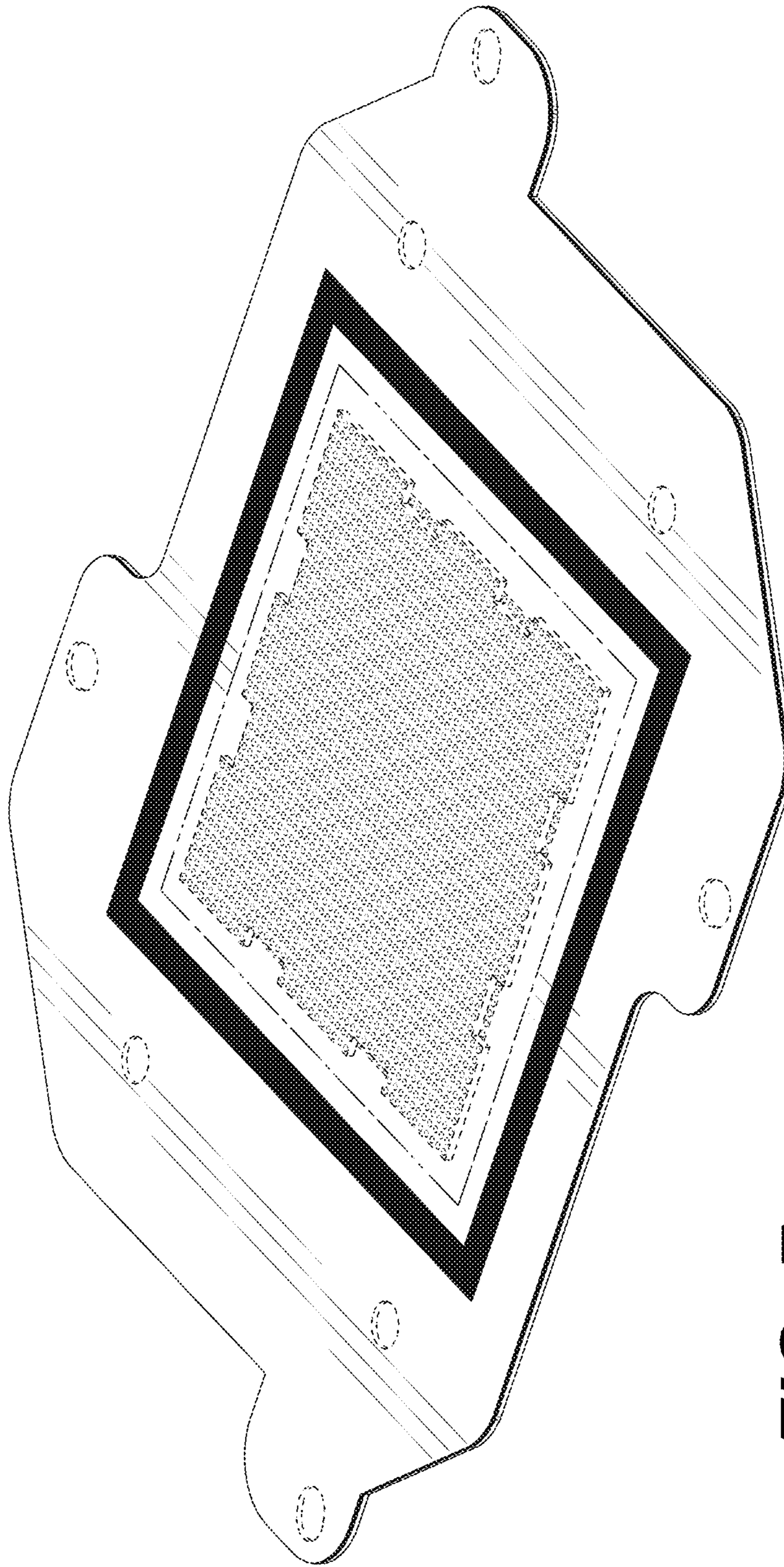


FIG. 7

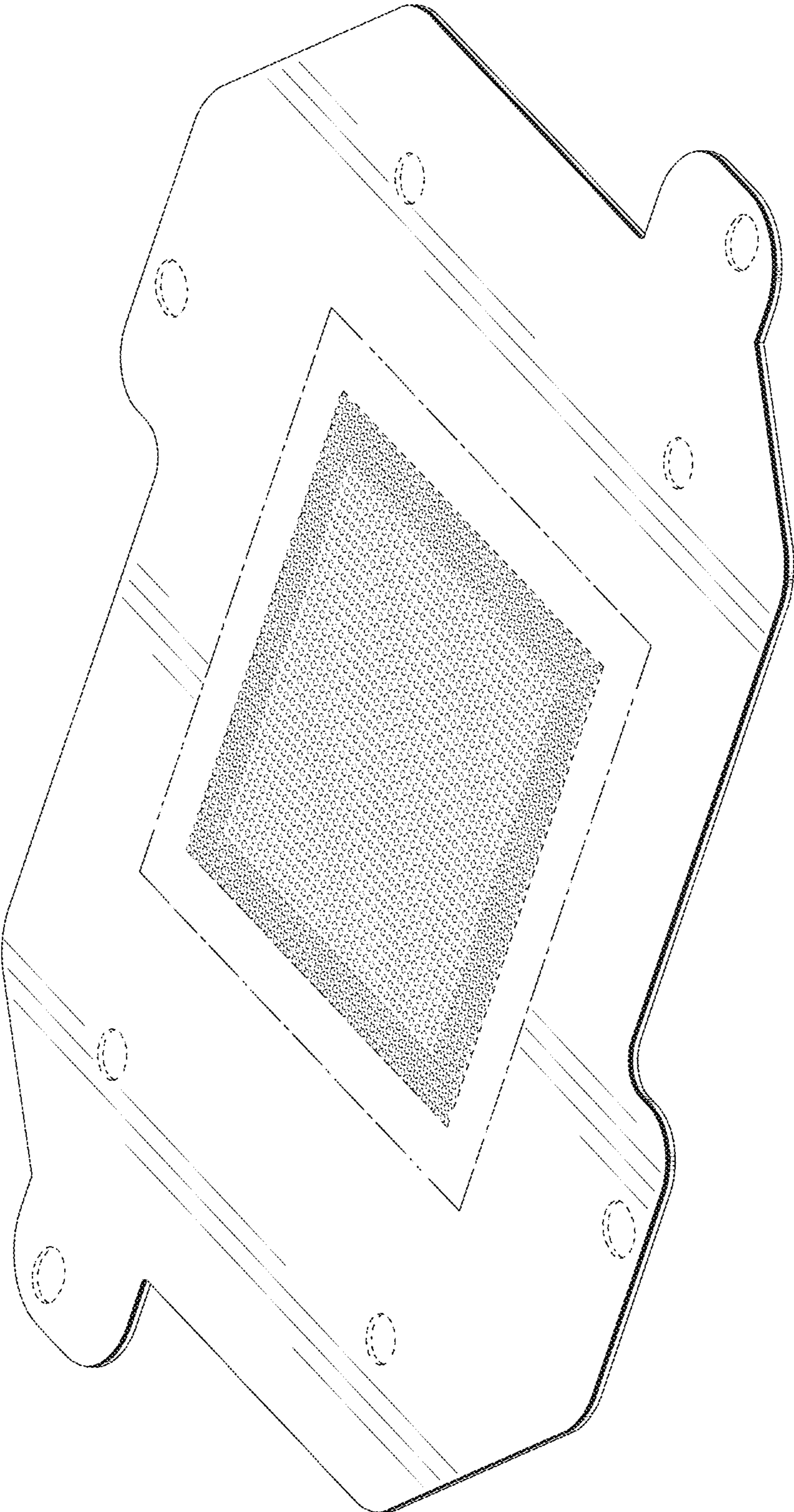


FIG. 8

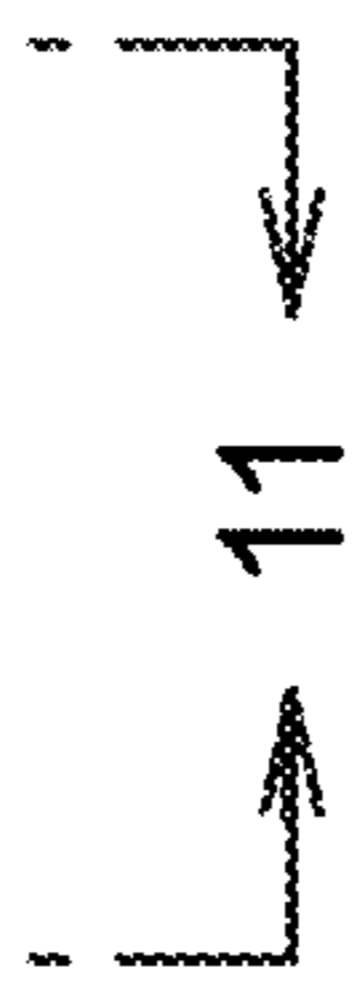
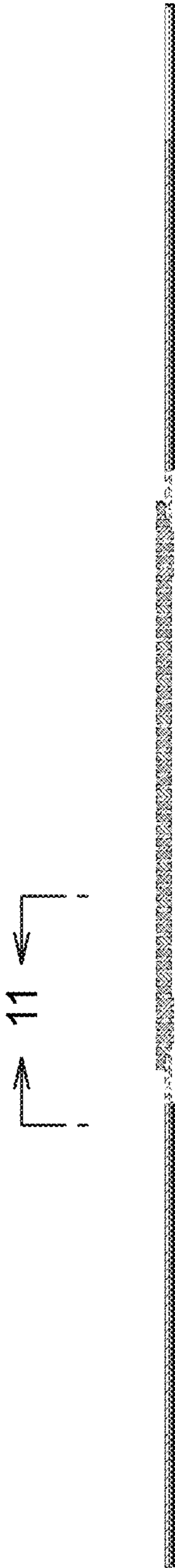


FIG. 9

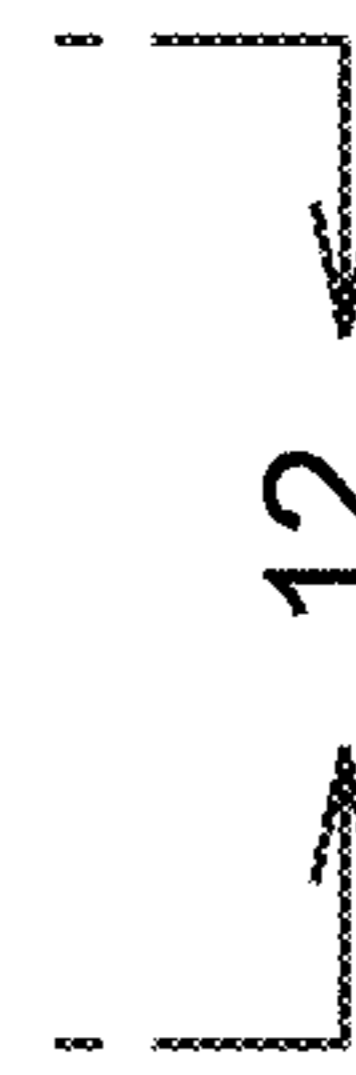
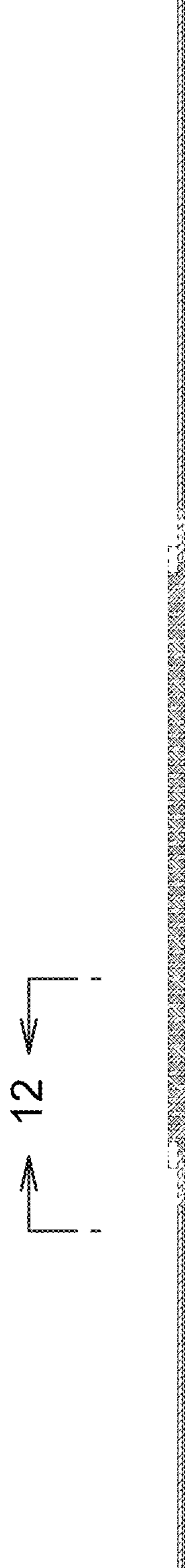


FIG. 10

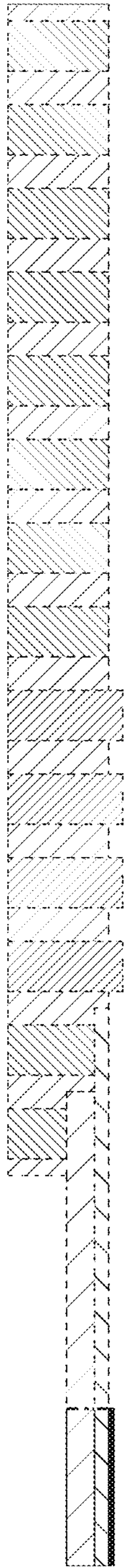


FIG. 11

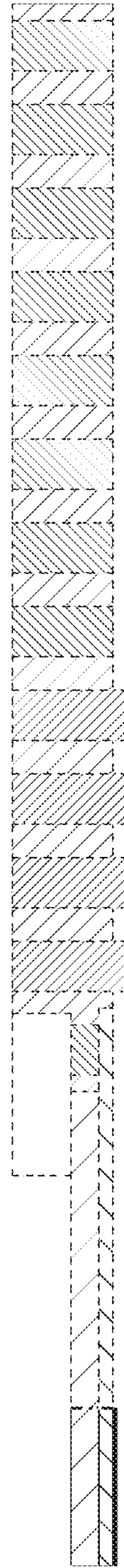


FIG. 12